S1: (arrow marks) PRs=1% +/-0.35% @ 1064 nm, AOI=45 deg + PRp=1%+/-0.35% @ 1064 nm, AOI=45 deg S2: ARsp<0.7% @ 1064 nm, AOI=45 deg

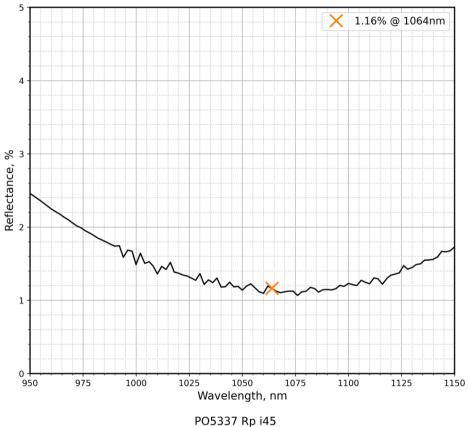
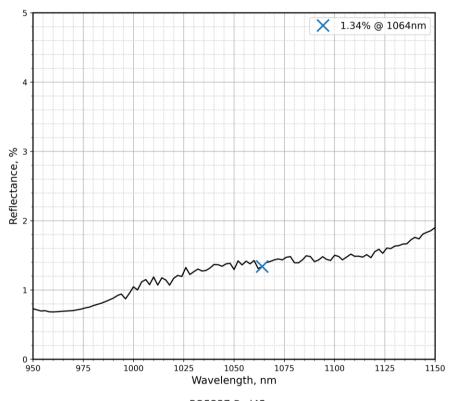


Fig. 1.

SIDE MEASURED: S1 only (grinded witness sample)

YOUR SIDEKICK FOR LASER OPTICS DEVELOPMENT

S1: (arrow marks) PRs=1% +/-0.35% @ 1064 nm, AOI=45 deg + PRp=1%+/-0.35% @ 1064 nm, AOI=45 deg S2: ARsp<0.7% @ 1064 nm, AOI=45 deg



PO5337 Rs i45

Fig. 2.

SIDE MEASURED: S1 only (grinded witness sample)

S1: (arrow marks) PRs=1% +/-0.35% @ 1064 nm, AOI=45 deg + PRp=1%+/-0.35% @ 1064 nm, AOI=45 deg S2: ARsp<0.7% @ 1064 nm, AOI=45 deg

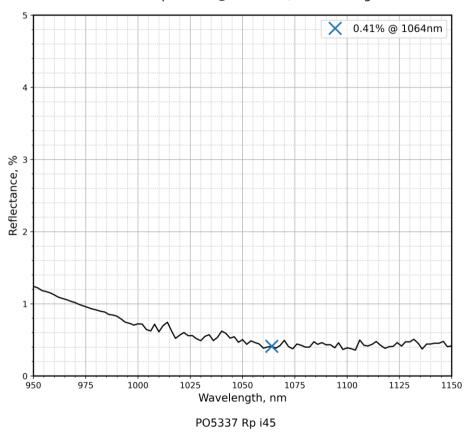


Fig. 3.

SIDE MEASURED: S2 only (grinded witness sample)

S1: (arrow marks) PRs=1% +/-0.35% @ 1064 nm, AOI=45 deg + PRp=1%+/-0.35% @ 1064 nm, AOI=45 deg S2: ARsp<0.7% @ 1064 nm, AOI=45 deg

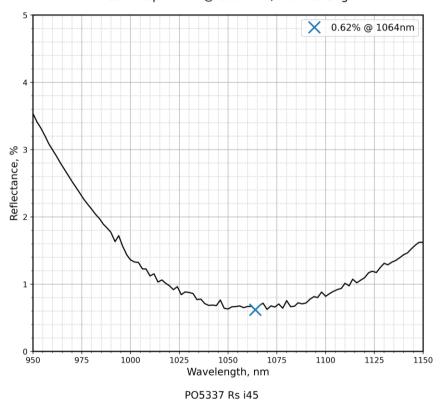


Fig. 4.

SIDE MEASURED: S2 only (grinded witness sample)